

Notice of References Cited	Application/Control No. 10/576,806	Applicant(s)/Patent Under Reexamination EONNET, YVES	
	Examiner MARCOS BATISTA	Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0172272 A1	09-2003	Ehlers et al.	713/170
*	B	US-6,782,080 B2	08-2004	Leivo et al.	379/93.04
*	C	US-7,231,025 B2	06-2007	Labaton, Isaac	379/188
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

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	V	
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